Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/550,535	TAKESHITA ET AL.	
Examiner	Art Unit	
Stephen J. Kalafut	1745	

	SEAR	CHED	
Class	Subclass	Date	Examiner
429	96, 97, 99, 100, 123	4/22/2007	SJK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEAR)	OTES CH STRATEGY	
	DATE	EXMR
eDAN Inventor Name Search	4/22/2007	SJK
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